Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/763,440	DE HAAN, WIEBE
Examiner	Art Unit
Vincent F. Boccio	2616

	SEARCHED				
Class	Subclass	Date	Examiner		
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	125-126				
	109,112				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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